

**PowerMOS transistor  
Fast Recovery Diode FET**

**BUK655-500A  
BUK655-500B  
BUK655-500C**

T-39-13

**GENERAL DESCRIPTION**

N-channel enhancement mode field-effect power transistor in a plastic envelope. FREDFET with fast recovery reverse diode, particularly suitable for motor control applications, eg. in full bridge configurations for which faster recovery characteristics simplify design for inductive loads.

**QUICK REFERENCE DATA**

| SYMBOL       | PARAMETER                        | MAX.                | MAX.                | MAX.                | UNIT     |
|--------------|----------------------------------|---------------------|---------------------|---------------------|----------|
|              | <b>BUK655</b>                    |                     |                     |                     |          |
| $V_{DS}$     | Drain-source voltage             | <b>-500A</b><br>500 | <b>-500B</b><br>500 | <b>-500C</b><br>500 | V        |
| $I_D$        | Drain current (DC)               | 5.7                 | 5.3                 | 5.0                 | A        |
| $P_{tot}$    | Total power dissipation          | 100                 | 100                 | 100                 | W        |
| $R_{DS(ON)}$ | Drain-source on-state resistance | 1.3                 | 1.5                 | 1.7                 | $\Omega$ |
| $t_{rr}$     | Diode reverse recovery time      | 250                 | 250                 | 250                 | ns       |

**MECHANICAL DATA**

Dimensions in mm

Net Mass: 2g

Pinning:

1 = Gate

2 = Drain

3 = Source

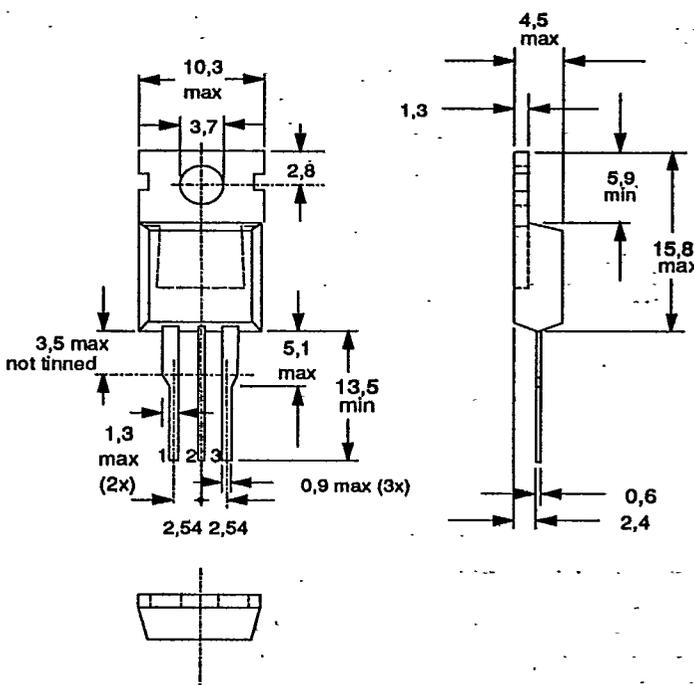
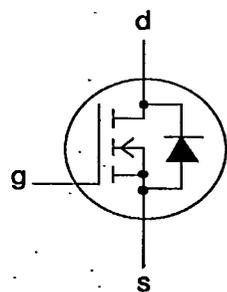


Fig.1 TO220AB; drain connected to mounting base.

**Notes**

1. Observe the general handling precautions for electrostatic-discharge sensitive devices (ESDs) to prevent damage to MOS gate oxide.
2. Accessories supplied on request: refer to Mounting instructions for TO220 envelopes.

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### RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

| SYMBOL       | PARAMETER                        | CONDITIONS                            | MIN. | MAX.  |       |       | UNIT             |
|--------------|----------------------------------|---------------------------------------|------|-------|-------|-------|------------------|
| $V_{DS}$     | Drain-source voltage             | -                                     | -    | 500   |       |       | V                |
| $V_{DGR}$    | Drain-gate voltage               | $R_{GS} = 20 \text{ k}\Omega$         | -    | 500   |       |       | V                |
| $\pm V_{GS}$ | Gate-source voltage              | -                                     | -    | 30    |       |       | V                |
| $I_D$        | Drain current (DC)               | $T_{mb} = 25 \text{ }^\circ\text{C}$  | -    | -500A | -500B | -500C | A                |
| $I_{D1}$     | Drain current (DC)               | $T_{mb} = 100 \text{ }^\circ\text{C}$ | -    | 5.7   | 5.3   | 5.0   | A                |
| $I_{DM}$     | Drain current (pulse peak value) | $T_{mb} = 25 \text{ }^\circ\text{C}$  | -    | 3.6   | 3.3   | 3.1   | A                |
| $P_{tot}$    | Total power dissipation          | $T_{mb} = 25 \text{ }^\circ\text{C}$  | -    | 100   |       |       | W                |
| $T_{stg}$    | Storage temperature              | -                                     | -55  | 150   |       |       | $^\circ\text{C}$ |
| $T_j$        | Junction Temperature             | -                                     | -    | 150   |       |       | $^\circ\text{C}$ |

### THERMAL RESISTANCES

|                                |                                 |
|--------------------------------|---------------------------------|
| From junction to mounting base | $R_{thj-mb} = 1.25 \text{ K/W}$ |
| From junction to ambient       | $R_{thj-a} = 60 \text{ K/W}$    |

### STATIC CHARACTERISTICS

 $T_{mb} = 25 \text{ }^\circ\text{C}$  unless otherwise specified

| SYMBOL        | PARAMETER                        | CONDITIONS   | MIN. | TYP. | MAX. | UNIT          |
|---------------|----------------------------------|--|------|------|------|---------------|
| $V_{(BR)DSS}$ | Drain-source breakdown voltage   | $V_{GS} = 0 \text{ V}; I_D = 0.25 \text{ mA}$                                    | 500  | -    | -    | V             |
| $V_{GS(TO)}$  | Gate threshold voltage           | $V_{DS} = V_{GS}; I_D = 1 \text{ mA}$  | 2.1  | 3.0  | 4.0  | V             |
| $I_{DSS}$     | Zero gate voltage drain current  | $V_{DS} = 500 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ\text{C}$  | -    | 2    | 20   | $\mu\text{A}$ |
| $I_{DSS}$     | Zero gate voltage drain current  | $V_{DS} = 500 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 125 \text{ }^\circ\text{C}$ | -    | 0.1  | 1.0  | mA            |
| $I_{GSS}$     | Gate source leakage current      | $V_{GS} = \pm 30 \text{ V}; V_{DS} = 0 \text{ V}$                                | -    | 10   | 100  | nA            |
| $R_{DS(ON)}$  | Drain-source on-state resistance | $V_{GS} = 10 \text{ V}; I_D = 2.5 \text{ A}$                                     | -    | 1.2  | 1.3  | $\Omega$      |
|               |                                  | BUK655-500A  | -    | 1.4  | 1.5  | $\Omega$      |
|               |                                  | BUK655-500B  | -    | 1.6  | 1.7  | $\Omega$      |
|               |                                  | BUK655-500C  | -    |      |      |               |

### DYNAMIC CHARACTERISTICS

 $T_{mb} = 25 \text{ }^\circ\text{C}$  unless otherwise specified

| SYMBOL     | PARAMETER                  | CONDITIONS   | MIN. | TYP. | MAX. | UNIT |
|------------|----------------------------|--|------|------|------|------|
| $g_{fs}$   | Forward transconductance   | $V_{DS} = 25 \text{ V}; I_D = 2.5 \text{ A}$                     | 2.3  | 3.1  | -    | S    |
| $C_{iss}$  | Input capacitance          | $V_{GS} = 0 \text{ V}; V_{DS} = 25 \text{ V}; f = 1 \text{ MHz}$ | -    | 750  | 1000 | pF   |
| $C_{oss}$  | Output capacitance         |  | -    | 90   | 140  | pF   |
| $C_{rs}$   | Feedback capacitance       |  | -    | 40   | 70   | pF   |
| $t_{don}$  | Turn-on delay time         | $V_{DD} = 30 \text{ V}; I_D = 2.6 \text{ A};$                    | -    | 10   | 45   | ns   |
| $t_r$      | Turn-on rise time          | $V_{GS} = 10 \text{ V}; R_{GS} = 50 \text{ } \Omega;$            | -    | 45   | 60   | ns   |
| $t_{doff}$ | Turn-off delay time        | $R_{gen} = 50 \text{ } \Omega$                                   | -    | 100  | 140  | ns   |
| $t_f$      | Turn-off fall time         |  | -    | 40   | 65   | ns   |
| $L_d$      | Internal drain inductance  | Measured from contact screw on tab to centre of die              | -    | 3.5  | -    | nH   |
| $L_d$      | Internal drain inductance  | Measured from drain lead 6 mm from package to centre of die      | -    | 4.5  | -    | nH   |
| $L_s$      | Internal source inductance | Measured from source lead 6 mm from package to source bond pad   | -    | 7.5  | -    | nH   |

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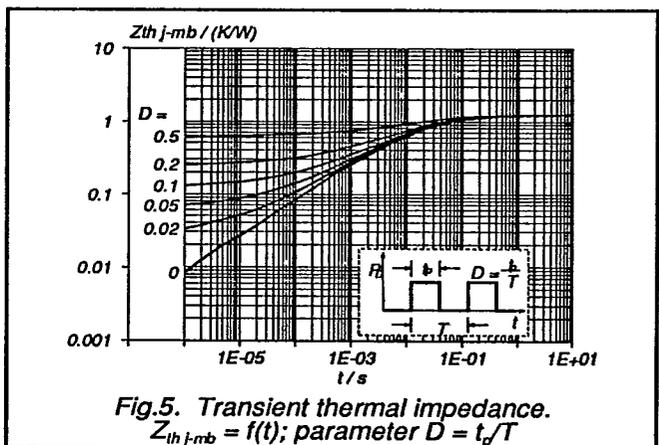
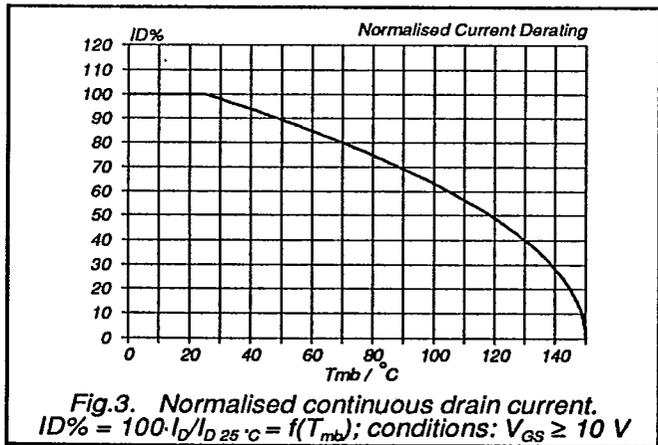
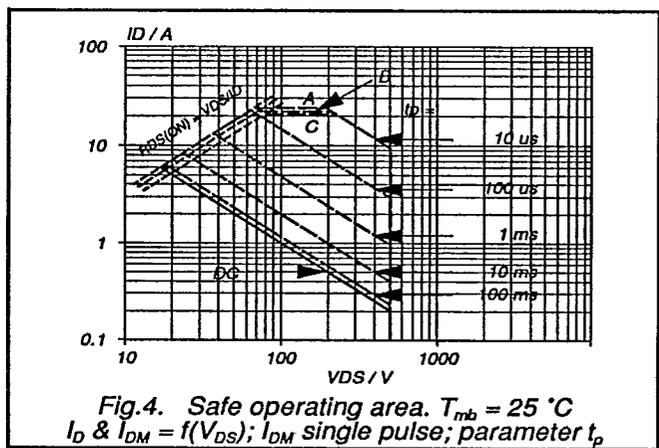
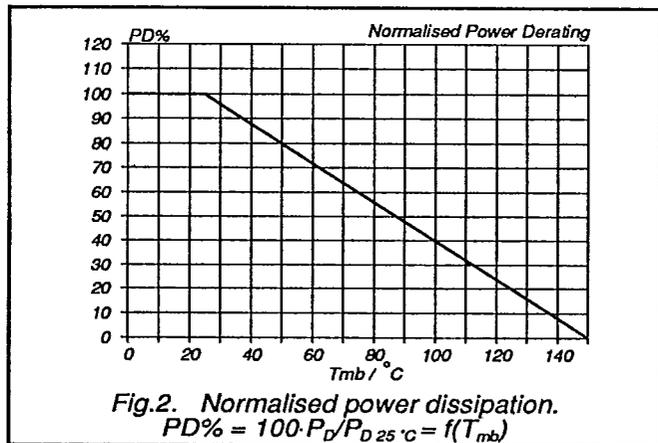
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**REVERSE DIODE RATINGS AND CHARACTERISTICS**

$T_{mb} = 25\text{ }^{\circ}\text{C}$  unless otherwise specified

| SYMBOL    | PARAMETER                        | CONDITIONS  | MIN.  | TYP.        | MAX.       | UNIT                           |
|-----------|----------------------------------|---|---|-------------|------------|--------------------------------|
| $I_{DR}$  | Continuous reverse drain current | -   | -   | -           | 5.7        | A                              |
| $I_{DRM}$ | Pulsed reverse drain current     | -   | -   | -           | 23         | A                              |
| $V_{SD}$  | Diode forward voltage            | $I_F = 5.7\text{ A};$<br>$V_{GS} = 0\text{ V}$        | -   | 1.1         | 1.5        | V                              |
| $t_{rr}$  | Reverse recovery time            | $I_F = 5.7\text{ A};$<br>$-di_F/dt =$                 | $T_J = 25\text{ }^{\circ}\text{C}$<br>$T_J = 125\text{ }^{\circ}\text{C}$ | 180<br>220  | 250<br>300 | ns<br>ns                       |
| $Q_{rr}$  | Reverse recovery charge          | $100\text{ A}/\mu\text{s};$<br>$V_{GS} = 0\text{ V};$ | $T_J = 25\text{ }^{\circ}\text{C}$<br>$T_J = 125\text{ }^{\circ}\text{C}$ | 0.65<br>2.6 | 1.2<br>5.0 | $\mu\text{C}$<br>$\mu\text{C}$ |
| $I_{rrm}$ | Reverse recovery current         | $V_R = 100\text{ V}$                                  | $T_J = 125\text{ }^{\circ}\text{C}$                                       | 15          | -          | A                              |



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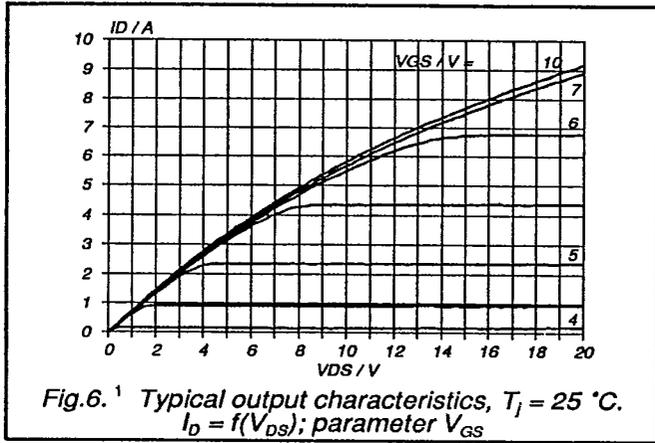


Fig. 6. <sup>1</sup> Typical output characteristics,  $T_j = 25^\circ\text{C}$ .  
 $I_D = f(V_{DS})$ ; parameter  $V_{GS}$

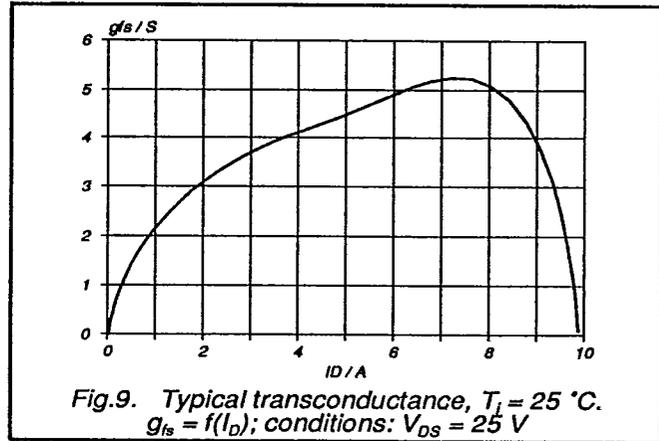


Fig. 9. Typical transconductance,  $T_j = 25^\circ\text{C}$ .  
 $g_m = f(I_D)$ ; conditions:  $V_{DS} = 25\text{ V}$

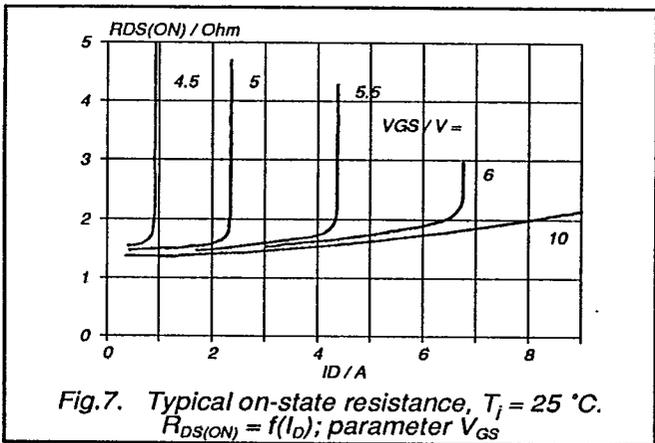


Fig. 7. Typical on-state resistance,  $T_j = 25^\circ\text{C}$ .  
 $R_{DS(ON)} = f(I_D)$ ; parameter  $V_{GS}$

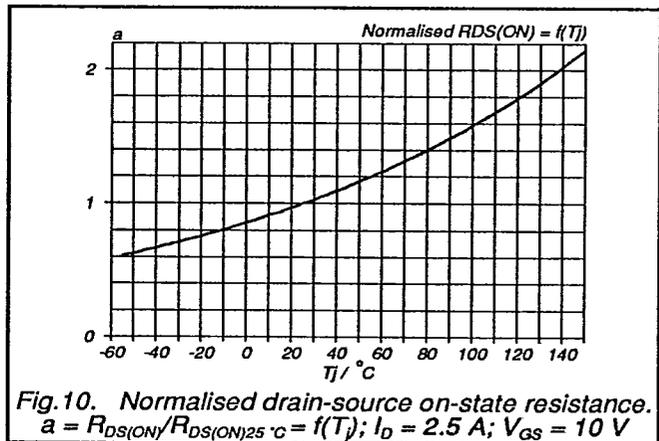


Fig. 10. Normalised drain-source on-state resistance.  
 $a = R_{DS(ON)}/R_{DS(ON)25^\circ\text{C}} = f(T_j)$ ;  $I_D = 2.5\text{ A}$ ;  $V_{GS} = 10\text{ V}$

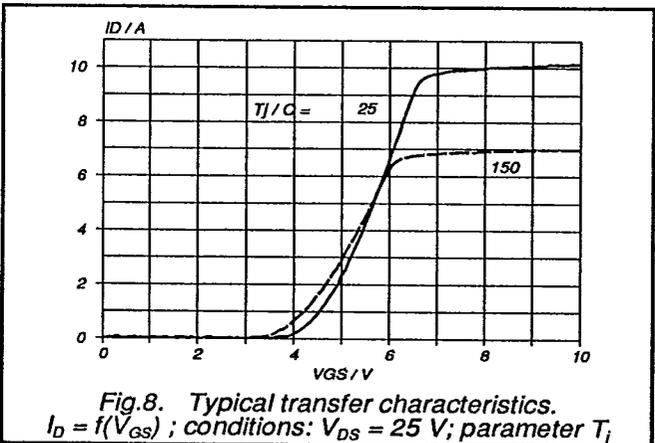


Fig. 8. Typical transfer characteristics.  
 $I_D = f(V_{GS})$ ; conditions:  $V_{DS} = 25\text{ V}$ ; parameter  $T_j$

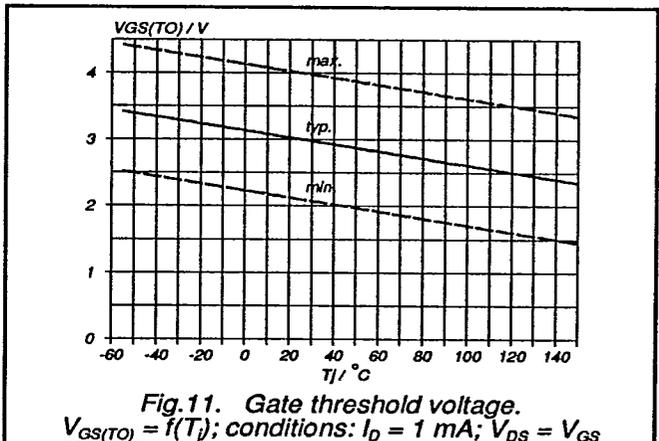


Fig. 11. Gate threshold voltage.  
 $V_{GS(TO)} = f(T_j)$ ; conditions:  $I_D = 1\text{ mA}$ ;  $V_{DS} = V_{GS}$

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